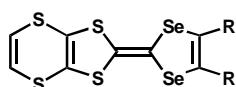


X or Acceptor	D : A	$\sigma_{rt} / \text{Scm}^{-1}$ (試料形状)	T _c / K [種類]	ref.	構造ref.	磁性ref.
Au(CN) ₂	2:1	2500 (s)	0.8 (5kbar) [SC]	1	9	17, 18
AuCl ₂	2:1	100 (s)	0.83 [SC]	2	12	
AuBr ₂	2:1	13 (s)	1.6 (1.5kbar) [SC]	3	6	18
AuBr ₂	2:1	200 (s)	1.9 [SC]	4	6	18
AuI ₂	2:1	300 (s)	0.55 (5kbar) [SC]	2	11	
I ₃	2:1	160 (s)	0.47 [SC]	5	13	18
IBr ₂	2:1	210 (s)	0.58 [SC]	5	10	
I ₂ Br	2:1	320 (s)	[M]	6		
BF ₄	2:1	130 (s)	40 [M-I]	7	10, 14	18
ClO ₄	2:1	260 (s)	32 [M-I]	6	15	19
ReO ₄	2:1	40 (s)	295 [M-I]	8	8	
FeBr ₄	2:1	14 (s)	200 [M-I]	16	16	16
PF ₆	2:1	300 (s)	semicond.	7	7	18
AsF ₆	2:1	200 (s)	semicond.	7		
SCN	2:1	80 (s)	[M]	6		

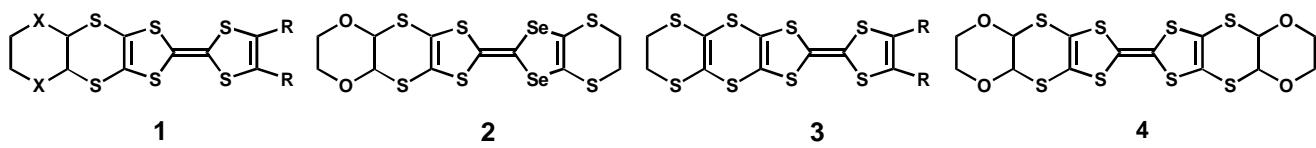
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R	X or Acceptor	D : A	σ_{rt} / Scm ⁻¹ [試料形状]	T _c / K [種類]	ref.	構造ref.	磁性ref.
CH ₃	I ₃	2:1	0.19 (s)	semicond.	1		
	AuCl ₂	1:1	0.64 (s)	semicond.	1		
	AuI ₂	3:2	3.2 (s)	semicond.	1		
	ClO ₄		6.1x10 ⁻⁴ (s)	semicond.	1		
	PF ₆	5:2	1.2x10 ⁻² (s)	semicond.	1		
	I ₃	5:2	13 (p)	260 [M-I]	1		
	AuI ₂	2:1	21 (p)	220 [M-I]	1		
	ClO ₄	2:1	135 (s)	M	2	2	2
	PF ₆	2:1	620 (s)	M	1	1	
	AsF ₆	2:1	125 (s)	M	2	2	2
-(CH ₂) ₃ -	I ₃	9:2	0.17 (s)	semicond.	1		
	PF ₆	5:2	13 (s)	M	1		
-S(CH ₂) ₂ S-	I ₃						
	PF ₆						

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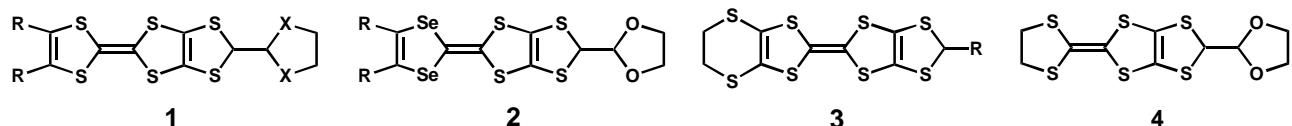
(2) H. Nishikawa, T. Sato, K. Kodama, I. Ikemoto, K. Kikuchi, H. Anzai, J. Yamada, *J. Mater. Chem.*, **9**, 693 (1999).



R	X	X or Acceptor	D : A	σ_{rt} / Scm ⁻¹ [試料形状]	T _c / K [種類]	ref.	構造ref.	磁性ref.
1 -S(CH ₂) ₂ S-	O	Cl ₂ Br	3:1	2.9 (p)	semicond.	1		
		Br ₂ Cl	4:1	2.4 (p)	semicond.	1		
		Br ₃	3:1	<10 ⁻⁶ (p)		1		
		Br ₂ I	5:3	<10 ⁻⁶ (p)		1		
		I ₂ Br	5:3	1.2 (p)	semicond.	1		
		I ₃	1:1	2.2 (s)	semicond.	1		
		Au(CN) ₂	2:1	13 (s)	30 [M-I]	1		
		AuCl ₂	1:1	12 (p)	semicond.	1		
		AuI ₂	1:1	0.033 (p)	semicond.	1		
		BF ₄	2:1	27 (s)	100 [M-I]	1	1	
		ClO ₄		1.0 (p)	semicond.	1		
		ReO ₄	3:1	0.43 (p)	semicond.	1		
		PF ₆	2:1	0.95 (p)	semicond.	1		
		AsF ₆	2:1	0.35 (p)	semicond.	1		
		SbF ₆	2:1	0.63 (s)	semicond.	1		
2 -S(CH ₂) ₂ S-	S	TCNQ	1:1	<10 ⁻⁶ (p)		3		
		TCNQ	5:1	0.014 (p)	semicond.	3		
3 -Se(CH ₂) ₂ Se-	O	I ₃ (needle)	2:1	60 (s)	250 [M-I]	2		
		I ₃ (plate)	2:0.8	20 (s)	45 [M-I]	5		
		AuI ₂	2:0.75	1.4 (s)	55 [M-I]	2	2	
		BF ₄	3:2	5.0 (s)	semicond.	2		
		ClO ₄	2:1	2.3 (s)	semicond.	2		
		PF ₆	2:1	0.62 (s)	semicond.	2		
		AsF ₆	5:2	5.1 (s)	semicond.	2		
		TCNQ		<10 ⁻⁶ (p)		2		
		I ₃	2:1	4.6x10 ⁻² (s)	semicond.	4		

	AuI ₂	3:2	0.11 (s)	semicond.	4			
	BF ₄	2:1	9.8x10 ⁻⁴ (s)	semicond.	4			
	ClO ₄	2:1	9.4x10 ⁻⁵ (s)	semicond.	4			
	PF ₆	2:1	2.6x10 ⁻⁷ (s)	semicond.	4			
	AsF ₆	2:1	6.0 (s)	M	4			
-O(CH ₂) ₂ O-	O	I ₃	1:1	4.5x10 ⁻⁷ (p)	semicond.	5		
	Au(CN) ₂	2:1	227 (s)	M	5			
	BF ₄	2:1	27 (s)	M	6	6		
	PF ₆	2:1	173 (s)	M	5			
2	I ₃	4:3	<10 ⁻⁶ (p)		5			
	BF ₄		3.2 (p)	semicond.	5			
	PF ₆	3:1	12 (p)	semicond.	5			
3	-S(CH ₂) ₂ S-	TCNQ	1:1	0.068 (p)	semicond.	3		
	I ₃		0.43	semicond.	3			
	AuI ₂		0.012	semicond.	7			
	ClO ₄		1.2 (p)	semicond.	3			
	BF ₄		0.0049	semicond.	7			
	AsF ₆		0.29	semicond.	7			
	SbF ₆		0.29	semicond.	7			
	Cu(NCS) ₂		0.019 (p)	semicond.	3			
4	I ₃	2:1			8	8	8	

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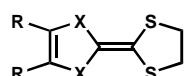


	R	X	X or Acceptor	D : A	σ_{rt} / Scm ⁻¹ (試料形状)	T _c / K [種類]	ref.	構造ref.	磁性ref.
1	H	O	TCNQ	5:4	9.1 (p)	semicond.	1		
	-S(CH ₂) ₂ S-	O	TCNQ	1:1	12 (p)	~ 150 [M-I]	1		
	-S(CH ₂) ₂ S-	I ₃		3:1	0.32 (p)	semicond.	2, 4		
			AuI ₂	5:3	13 (s)	35 [M-I]	2, 4		
			BF ₄	2:1	7.0 (s)	110 [M-I]	2, 4		
			ClO ₄		0.095 (p)	semicond.	2, 4		
			AsF ₆	3:1	19 (s)	60 [M-I]	2, 4		
			TCNQ		<10 ⁻⁶ (s)		2		
2			TCNQ	1:2	<10 ⁻⁶ (p)		1		
3	Me		AuI ₂	5:2	8.1x10 ⁻³ (s)	semicond.	3		
			BF ₄	3:2	5.5x10 ⁻⁴ (s)	semicond.	3		

(3-仮3)

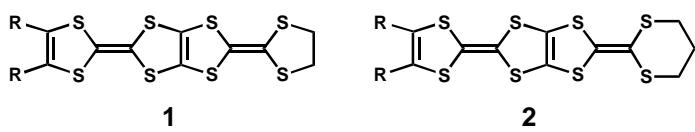
	<chem>ClO4</chem>		4.2×10^{-3} (s)	semicond.	3
	<chem>PF6</chem>	5:2	1.4×10^{-3} (s)	semicond.	3
Et	<chem>AuI2</chem>	1:1	1.3×10^{-3} (p)	semicond.	3
	<chem>BF4</chem>	5:2	2.5 (p)	semicond.	3
	<chem>ClO4</chem>		26 (p)	~ 230 [M-I]	3
	<chem>PF6</chem>	5:2	17 (p)	~ 170 [M-I]	3
4	<chem>TCNQ</chem>	1:2	$<10^{-6}$ (p)		1

- (1) J. Yamada, M. Hamasaki, O. Jinji, S. Tanaka, K. Hagiya, and H. Anzai, *Tetrahedron Lett.*, **38**, 3439 (1997).
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(3) J. Yamada, K. Aoki, S. Nakatsuji, H. Nishikawa, I. Ikemoto, and K. Kikuchi, *Tetrahedron Lett.*, **40**, 6635 (1999).
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R	X	X or Acceptor	D : A	$\sigma_{rt} / \text{Scm}^{-1}$ (試料形状)	T _c / K [種類]	ref.	構造ref.	磁性ref.
<chem>-SCH2S-</chem>	S	<chem>AuCl2</chem>	5:2	5.8×10^{-2} (p)	semicond.	1		
		<chem>AuI2</chem>	2:1	60 (s)	M	1		
		<chem>BF4</chem>	7:2	3.7×10^{-3} (p)	semicond.	1		
		<chem>TCNQ</chem>		$<10^{-6}$ (s)		1		
<chem>-S(CH2)2S-</chem>	S	<chem>I3(TCE)</chem>	1:1	$<10^{-6}$ (s)		1		
		<chem>I3(o-C6H4Cl2)</chem>	10:9	1.2×10^{-3} (s)	semicond.	1		
		<chem>BF4</chem>	3:2	7.8×10^{-2} (p)	semicond.	1		
		<chem>ClO4</chem>	3:2	1.4×10^{-2} (p)	semicond.	1		
		<chem>ReO4</chem>	5:4	1.3×10^{-4} (p)	semicond.	1		
		<chem>PF6</chem>	2:1	$<10^{-6}$ (s)		1		
		<chem>AsF6</chem>	1:1	$<10^{-6}$ (s)		1		
		<chem>TCNQ</chem>		$<10^{-6}$ (s)		1		
<chem>-SCH=CHS-</chem>		<chem>BF4</chem>	4:3	5.2×10^{-3} (p)	semicond.	1		
		<chem>ClO4</chem>		3.4×10^{-3} (p)	semicond.	1		
		<chem>TCNQ</chem>		$<10^{-6}$ (s)		1		
<chem>CH3</chem>	Se	<chem>ClO4</chem>	2:1	$<10^{-6}$ (p)	semicond.	1		
		<chem>TCNQ</chem>		$<10^{-6}$ (s)		1		
<chem>-(CH2)3-</chem>		<chem>ClO4</chem>	2:1	$<10^{-6}$ (p)	semicond.	1		
		<chem>TCNQ</chem>		$<10^{-6}$ (s)		1		
<chem>-S(CH2)2S-</chem>		<chem>BF4</chem>	3:2	8.9×10^{-2} (p)	semicond.	1		
		<chem>ClO4</chem>	5:3	2.3 (p)	semicond.	1		
		<chem>ReO4</chem>	3:2	1.0 (p)	semicond.	1		

- (1) J. Yamada, S. Takasaki, M. Kobayashi, H. Anzai, N. Tajima, M. Tamura, Y. Nishio, and K. Kajita, *Chem. Lett.*, 1069 (1995).



R	X or Acceptor	D : A	$\sigma_{rt} / \text{Scm}^{-1}$ (試料形状)	T _c / K [種類]	ref.	構造ref.	磁性ref.	
1	H	<chem>TCNQ</chem>	1:1	45 (p)	110 [M-I]	1, 2		

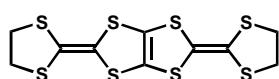
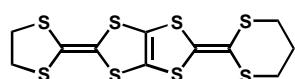
(3-仮4)

		AuI ₂	5:4	450 (s)	M	1, 2	
		ClO ₄		17 (s)	32 [M-I]	1, 2	
		AsF ₆	5:4	4.2 (p)	150 [M-I]	1, 2	
SMe	TCNQ		1:1	0.08 (p)	semicond.	1, 2	
		I ₃	4:1	7.0 (s)	semicond.	1, 2	
		BF ₄	5:2	33 (s)	semicond.	1, 2	
		ClO ₄		22 (s)	semicond.	1, 2	
		PF ₆	5:2	130 (s)	M	1, 2	
		AsF ₆	5:2	170 (s)	M	1, 2	
-S(CH ₂) ₂ S-	TCNQ		5:3	8.6 (p)	semicond.	1, 2	
		I ₃	5:2	9.6 (p)	160 [M-I]	1, 2	
		AuI ₂	2:1	14 (s)	M	1, 2	1
		BF ₄	2:1	2.3 (p)	semicond.	1, 2	
		ClO ₄		18 (p)	semicond.	1, 2	
		PF ₆	2:1	58 (s)	M	1, 2	
-SCH ₂ S-	TCNQ		2:1	16 (s)	M	1, 2	
		I ₃	2:1	3.1 (p)	semicond.	1, 2	
		AuI ₂	2:1	1.3 (p)	semicond.	1, 2	
			5:4	7.8 (p)	semicond.	2, 3	
		I ₃	2:1	0.85 (p)	semicond.	2, 3	
		AuI ₂	2:1	1.9 (p)	semicond.	2, 3	
2	H	ClO ₄		2.0 (p)	semicond.	2, 3	
		AsF ₆	5:3	1.2 (p)	semicond.	2, 3	
		TCNQ	5:4	13 (p)	semicond.	2, 3	
		I ₃	3:2	3.9 (p)	semicond.	2, 3	
		AuI ₂	2:1	710 (s)	250 [M-I]	2, 3	
		ClO ₄		0.46 (s)	semicond.	2, 3	
-S(CH ₂) ₂ S-	TCNQ	AsF ₆	3:2	11 (s)	semicond.	2, 3	
		I ₃	2:1	1.1 (p)	semicond.	2, 3	
		AuI ₂	2:1	36 (p)	165 [M-I]	2, 3	3
		BF ₄	2:1	52 (p)	170 [M-I]	2, 3	
		ClO ₄		21 (p)	125 [M-I]	2, 3	
		PF ₆	2:1	44 (p)	60 [M-I]	2, 3	
-SCH ₂ S-	TCNQ	AsF ₆	3:2	12 (p)	95 [M-I]	2, 3	
		AuI ₂	2:1	71 (p)	215 [M-I]	2, 3	
		ClO ₄		0.018 (p)	semicond.	2, 3	
		AsF ₆	1:1	0.037 (p)	semicond.	2, 3	

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**1****2**

X or Acceptor	D : A	$\sigma_{rt} / \text{Scm}^{-1}$ (試料形状)	T _c / K [種類]	ref.	構造ref.	磁性ref.
1	TCNQ	1:1	2.0×10^{-7} (s)	semicond.	1	
	TCNQF ₄	3:2	5.6×10^{-5} (p)	semicond.	1	

(3-仮5)

	I ₃	2:1	230	M	1	
	AuI ₂	2:1	49	M	1	
	BF ₄	2:1	33	M	1	
	ClO ₄		106	M	1	
	PF ₆	2:1	102	M	1	1
	AsF ₆	2:1	49	M	1	
2	I ₃	3:1	53	M	3	
	BF ₄	2:1	2.3	M	3	
	ClO ₄		0.42	semicond.	3	
	AsF ₆	2:1	0.15	semicond.	3	

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